STL120N8F7



N-channel 80 V, 3.7 mΩ typ., 120 A STripFET™ F7 Power MOSFET in a PowerFLAT™ 5x6 package

Datasheet - production data

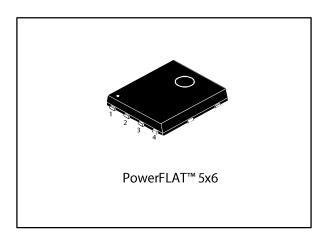
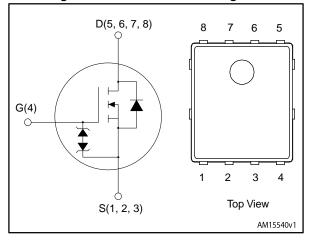


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	ΙD	Ртот
STL120N8F7	80 V	$4.4~\text{m}\Omega$	120 A	140 W

- Among the lowest R_{DS(on)} on the market
- Excellent figure of merit (FoM)
- Low C_{rss}/C_{iss} ratio for EMI immunity
- High avalanche ruggedness

Applications

• Switching applications

Description

This N-channel Power MOSFET utilizes STripFET™ F7 technology with an enhanced trench gate structure that results in very low onstate resistance, while also reducing internal capacitance and gate charge for faster and more efficient switching.

Table 1: Device summary

Order code	Marking	Package	Packing	
STL120N8F7	120N8F7	PowerFLAT™ 5x6	Tape and reel	

Contents STL120N8F7

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STL120N8F7 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage	80	V
V_{GS}	Gate-source voltage	±20	V
I _D ⁽¹⁾	Drain current (continuous) at T _{case} = 25 °C	120	Λ
ID	Drain current (continuous) at T _{case} = 100 °C	90	Α
I _{DM} ⁽¹⁾⁽²⁾	Drain current (pulsed)	480	Α
Ip ⁽³⁾	Drain current (continuous) at T _{pcb} = 25 °C	23	Α
ID(e)	Drain current (continuous) at T _{pcb} = 100 °C	17	А
I _{DM} ⁽²⁾⁽³⁾	Drain current (pulsed)	92	Α
P _{TOT} ⁽¹⁾	Total dissipation at T _{case} = 25 °C	140	W
P _{TOT} (3)	Total dissipation at T _{pcb} = 25 °C	4.8	W
T _{stg}	Storage temperature	55 to 175	°C
Tj	Operating junction temperature	-55 to 175	C

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-pcb} ⁽¹⁾	Thermal resistance junction-pcb	31.3	°C/W
R _{thj-case}	Thermal resistance junction-case	1.05	C/VV

Notes

 $^{(1)}$ When mounted on a 1-inch² FR-4 board, 2oz Cu, t < 10 s

 $^{^{(1)}}$ This value is rated according to $R_{\text{thj-c.}}$

⁽²⁾ Pulse width is limited by safe operating area.

 $^{^{(3)}}$ This value is rated according to $R_{\text{thj-pcb}}$

Electrical characteristics STL120N8F7

2 Electrical characteristics

(T_{case} = 25 °C unless otherwise specified)

Table 4: Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	80			V
I _{DSS}	Zero gate voltage drain current	V _{GS} = 0 V, V _{DS} = 80 V			1	μΑ
Igss	Gate-body leakage current	V _{DS} = 0 V, V _{GS} = 20 V			100	nA
V _{GS(th)}	Gate threshold voltage	V _{DS} = V _{GS} , I _D = 250 μA	2		4	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 11.5 A		3.7	4.4	mΩ

Table 5: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		1	4570	ı	
Coss	Output capacitance	V _{DS} = 25 V, f = 1 MHz, V _{GS} = 0 V	1	800	ı	pF
Crss	Reverse transfer capacitance		ı	64	ı	'
Q_g	Total gate charge	V _{DD} = 40 V, I _D = 23 A,	1	60	ı	
Qgs	Gate-source charge V _{GS} = 10 V (see <i>Figure 14</i> :		-	24.7	-	nC
Q _{gd}	Gate-drain charge	"Gate charge test circuit")	-	14.8	-	

Table 6: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	V _{DD} = 40 V, I _D = 11.5 A	ı	34.5	1	
t _r	Rise time	$R_G = 4.7 \Omega$, $V_{GS} = 10 V$ (see Figure 13: "Switching times test	ı	16.8	ı	
t _{d(off)}	Turn-off delay time	circuit for resistive load" and	ı	60	ı	ns
t _f	Fall time	Figure 18: "Switching time waveform")	-	15.4	-	

Table 7: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{SD} ⁽¹⁾	Forward on voltage	V _{GS} = 0 V, I _{SD} = 23 A	-		1.2	V
t _{rr}	Reverse recovery time	I _{SD} = 23 A, di/dt = 100 A/µs,	-	48.6		ns
Qrr	Reverse recovery charge	V _{DD} = 64 V (see Figure 15: "Test circuit for inductive load	-	65.6		nC
I _{RRM}	Reverse recovery current	switching and diode recovery times")	-	2.7		Α

Notes:



 $^{^{(1)}}$ Pulse test: pulse duration = 300 $\mu s,$ duty cycle 1.5%.

2.1 Electrical characteristics (curves)

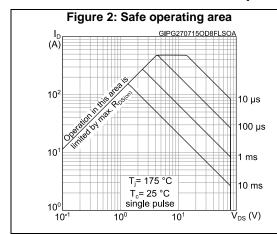
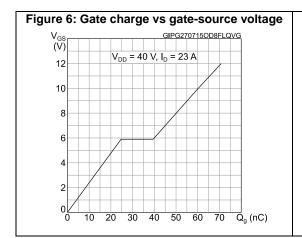
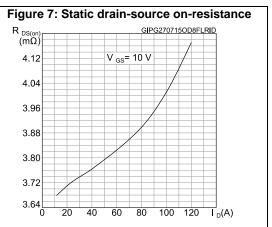


Figure 3: Thermal impedance K GIPGZ707150D8FLZTH δ =0.5 δ =0.01 δ =0.01 δ =0.01 δ =0.01 δ =0.02 δ =0.01 δ Single pulse δ =1,07 δ =1,08 δ =1,09 δ =1,09





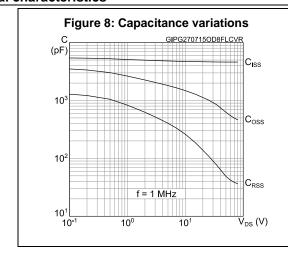
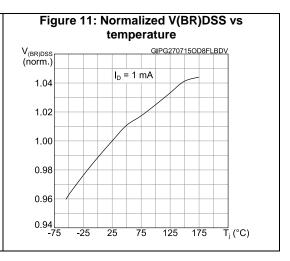
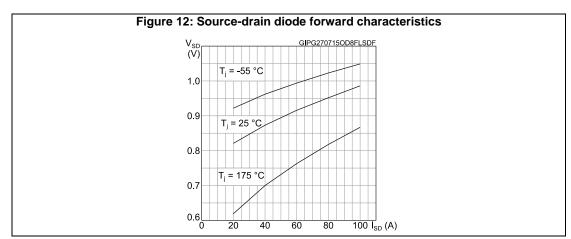


Figure 9: Normalized gate threshold voltage vs temperature V_{GS(th)} (norm.) GIPG270715OD8FLVTH I_D = 250 μA 1.1 1.0 0.9 0.8 0.7 0.6 0.5 125 175 25 75 T_i (°C)

Figure 10: Normalized on-resistance vs temperature R_{DS(on)} (norm.) GIPG270715OD8FLRON 2.0 V_{GS} = 10 V 1.8 1.6 1.4 1.2 1.0 0.8 0.6 -75 T_j (°C) 75 125

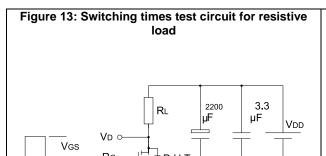


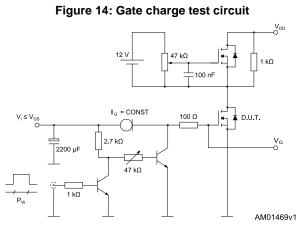


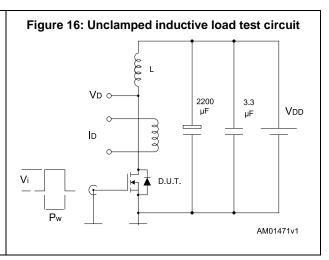
STL120N8F7 Test circuits

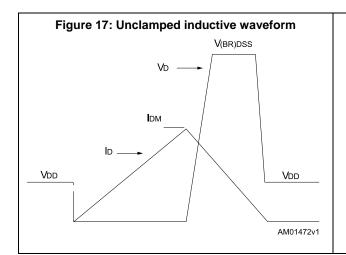
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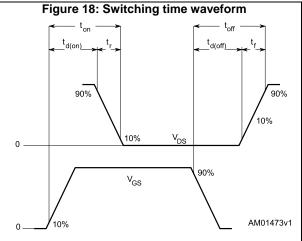
3 Test circuits











4 Package information

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In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

STL120N8F7 Package information

4.1 PowerFLAT™ 5x6 type C package

Figure 19: PowerFLAT™ 5x6 type C package outline

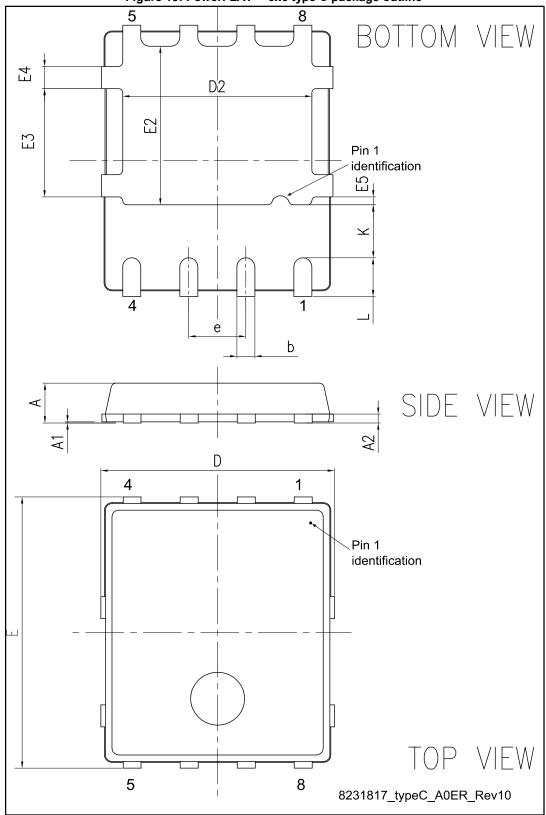
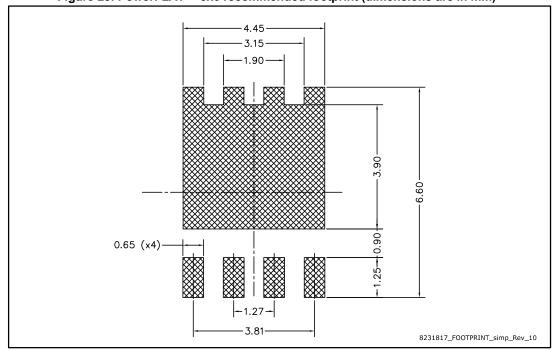


Table 8: PowerFLAT™ 5x6 type C mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α	0.80		1.00
A1	0.02		0.05
A2		0.25	
b	0.30		0.50
D		5.20	
E		6.15	
D2	4.11		4.31
E2	3.50		3.70
е		1.27	
e1		0.65	
L	0.715		1.015
K	1.05		1.35
E3	2.35		2.55
E4	0.40		0.60
E5	0.08		0.28

Figure 20: PowerFLAT™ 5x6 recommended footprint (dimensions are in mm)



STL120N8F7 Package information

4.2 PowerFLAT™ 5x6 packing information

Figure 21: PowerFLAT™ 5x6 tape (dimensions are in mm)

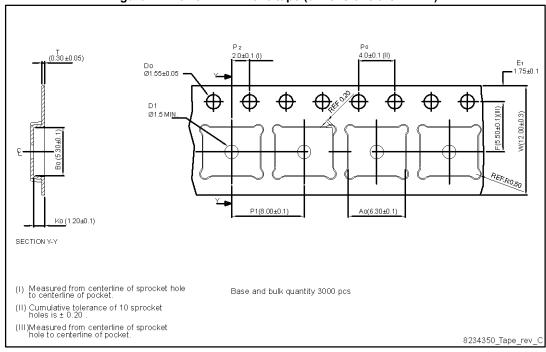
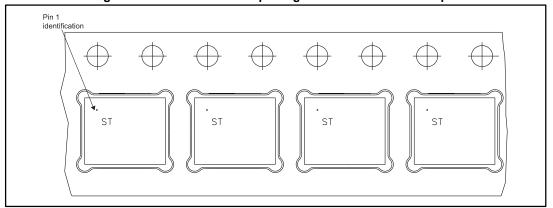


Figure 22: PowerFLAT™ 5x6 package orientation in carrier tape



PART NO.

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R25.

Figure 23: PowerFLAT™ 5x6 reel

STL120N8F7 Revision history

5 Revision history

Table 9: Document revision history

Date	Revision	Changes
09-Dec-2014	1	First release.
27-Jul-2015	2	Text and formatting changes throughout document. Datasheet status promoted from preliminary data to production data. In section Electrical characteristics: - updated tables Dynamic, Switching times and Source-drain diode - added section Electrical characteristics (curves)

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